Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,719	CHEN ET AL.	
Examiner	Art Unit	
John P. Leubecker	3739	

	SEAR	CHED	
Class	Subclass	Date	Examiner
Updated	Search	8/25/2005	JPL
	1		
	`		
<u>-</u>			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	,		
	,		
See Interference Search History		9/14/2005	JPL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		-		
		<u> </u>		